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CONSOLIDATED



Thermal-links – Requirements and application guide





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IEC 60691:2015+AMD1:2019 CSV - 3 -© IEC 2019 11.5 12 13 Annex B (normative) Alternative ageing test for thermal-links with $T_{\rm h}$ greater than C.1 C.2 C.3 C.4 C.5 C.6 D.1 D.2 Annex H (normative) Requirements for thermal-link packaged assemblies40 Bibliography......43 Figure E.1 – Conditioning time versus oven temperature for proposed temperature Table 2 - Strength of leads and terminal parts - Minimum required tensile and thrust

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

THERMAL-LINKS – REQUIREMENTS AND APPLICATION GUIDE

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This Consolidated version of IEC 60691 bears the edition number 4.1. It consists of the fourth edition (2015-10) [documents 32C/512/FDIS and 32C/515/RVD] and its corrigendum (2016-08), and its amendment 1 (2019-01) [documents 32C/548/FDIS and 32C/559/RVD]. The technical content is identical to the base edition and its amendment.

In this Redline version, a vertical line in the margin shows where the technical content is modified by amendment 1. Additions are in green text, deletions are in strikethrough red text. A separate Final version with all changes accepted is available in this publication. IEC 60691:2015+AMD1:2019 CSV © IEC 2019

International Standard IEC 60691 has been prepared by subcommittee 32C: Miniature fuses, of IEC technical committee 32: Fuses.

This fourth edition constitutes a technical revision.

This fourth edition includes the following significant technical changes with respect to the previous edition:

- a) requirements for thermal-link packaged assemblies;
- b) renew the requirements and definitions for $T_{\rm h}$ -test;
- c) change starting temperature for interrupt current test;
- d) clarify requirements for marking (packing label);
- e) minimum Proof Tracking Index 175 instead 120.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

The basis for this standard is the harmonization of the USA national standard, UL 1020, fifth

edition (withdrawn 2003), and IEC 60691:1993, together with its Amendment 1:1995 and Amendment 2:2000.

The following differing practices of a less permanent nature exist in the country indicated below:

- Annex C is required to be declared in the USA;
- Annex E is required in the USA, if applicable;
- Annex F is required to be declared in the USA.

In this standard, the following type is used:

- compliance statements: in italic type.

The committee has decided that the contents of the base publication and its amendment will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
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INTRODUCTION

- 6 -

Thermal-links, defined as non-resettable devices functioning once only without refunctioning, are widely applied for the thermal protection of equipment in which, under fault (abnormal) conditions, one or more parts may reach hazardous temperatures.

, he parale is require. As these devices have several aspects in common with miniature fuse-links and are used for obtaining a comparable degree of protection, this standard has endeavoured to lay down a number of basic requirements for such devices.

THERMAL-LINKS – REQUIREMENTS AND APPLICATION GUIDE

1 Scope

This International Standard is applicable to thermal-links intended for incorporation in electrical appliances, electronic equipment and component parts thereof, normally intended for use indoors, in order to protect them against excessive temperatures under abnormal conditions.

NOTE 1 The equipment is not designed to generate heat.

NOTE 2 The effectiveness of the protection against excessive temperatures logically depends upon the position and method of mounting of the thermal-link, as well as upon the current which it is carrying.

This standard may be applicable to thermal-links for use under conditions other than indoors, provided that the climatic and other circumstances in the immediate surroundings of such thermal-links are comparable with those in this standard.

This standard may be applicable to thermal-links in their simplest forms (e.g. melting strips or wires), provided that molten materials expelled during function cannot adversely interfere with the safe use of the equipment, especially in the case of hand-held or portable equipment, irrespective of its position.

Annex H of this standard is applicable to thermal-link packaged assemblies where the thermal-link(s) has already been approved to this standard but packaged in a metallic or non-metallic housing and provided with terminals/wiring leads.

This standard is applicable to thermal-links with a rated voltage not exceeding 690 V a.c. or d.c. and a rated current not exceeding 63 A.

The objectives of this standard are:

- a) to establish uniform requirements for thermal-links,
- b) to define methods of test,
- c) to provide useful information for the application of thermal-links in equipment.

This standard is not applicable to thermal-links used under extreme conditions such as corrosive or explosive atmospheres.

This standard is not applicable to thermal-links to be used in circuits on a.c. with a frequency lower than 45 Hz or higher than 62 Hz.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60065:2014, Audio, video and similar electronic apparatus – Safety requirements

IEC 60112:2003, Method for the determination of the proof and the comparative tracking indices of solid insulating materials IEC 60112:2003/AMD1:2009

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IEC 60127-2:2014, Miniature fuses – Part 2: Cartridge fuse-links

IEC 60216-5:2008, Electrical insulating materials – Thermal endurance properties – Part 5: Determination of relative thermal endurance index (RTE) of an insulating material

IEC 60664-1:2007, Insulation coordination for equipment within low-voltage systems – Part 1: *Principles, requirements and tests*

IEC 60695-2-12:2010, Fire hazard testing – Part 2-12: Glowing/hot-wire based test methods – Glow-wire flammability index (GWFI) test method for materials IEC 60695-2-12:2010/AMD1:2014

IEC 60695-2-13:2010, Fire hazard testing – Part 2-13: Glowing/hot-wire based test methods – Glow-wire ignition temperature (GWIT) test method for materials IEC 60695-2-13:2010/AMD1:2014

IEC 60695-10-2:2014, Fire hazard testing – Part 10-2: Abnormal heat – Ball pressure test method

IEC 60695-11-10:2013, Fire hazard testing – Part 11-10: Test flames – 50 W horizontal and vertical flame test methods

IEC 60730-1:2013, Automatic electrical controls – Part 1: General requirements

IEC 61210:2010, Connecting devices – Flat quick-connect terminations for electrical copper conductors – Safety requirements

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

3.1

clearance

shortest distance in air between two conductive parts

3.2

creepage distance

shortest distance along the surface of insulating material between two conductive parts

3.3

holding temperature

 T_{h}

maximum temperature of the thermal-link at which it will not change its state of conductivity during a specified time at the rated current

Note 1 to entry: The minimum permissible value of T_h is 35 °C.

3.4

homogeneous series

series of thermal-links having the same external dimensions and common overall construction, deviating from each other only in such characteristics (including ratings) that, for a given test,